



SATHYABAMA

Institute of Science and Technology
(Deemed to be University)

Jeppiaar Nagar, Rajiv Gandhi Salai, Chennai – 600119, India



Six Days Students Development Programme
on

**“Material Processing and Flaw Detection by Non-Destructive
Test Methods”**



Jointly Organized by

Centre for Quality Assurance and NDE ;

Departments of Mech.Engg. & Physics & ASNT India Section

Date: 17th August 2020 to 25th August 2020, Time: 2.00 PM to 4.00 PM



Patrons

Dr. Mariazeena Johnson
Chancellor

Dr. Marie Johnson
President

Dr. T. Sasipraba
Vice Chancellor

Organizing Secretary

Dr. B. Sheela Rani
Director (Research)

Convener

Mr. M.M.Nickolas, CQNDE

Co-conveners

**Dr.S.Ravichandran, Prof. &
Head, Dept. of Physics,
Mr.S.Lakshmi Sankar, Asst.
Prof. Dept.of Mech.Engg.**



Shri. Janakaraj

Managing Director, Boon Institute of NDE

Title : NDE–Introduction

Date : 17.8.2020



Shri. Prakash Gokulanandam

**Chief Executive , Inico Inspection
Services & Secretary ASNT India Section**

Title : NDE–Qualification & Certification

Date : 17.8.2020



Shri. M.M. Nickolas, CQNDE, SIST

Title: NDE–Materials Processing & Defects

Date : 18.8.2020

Title: Surface NDT Methods

Date : 19.8.2020



**Shri. S.S. Ananthan, NABL, Assessor &
Consultant TRYCAE Industrial Engg. Pvt Ltd**

**Title : Radiography Testing & Application
in Industries**

Date : 20.8.2020

**Registration Fee :
Rs. 300/-**



**Dr.S.Ravichandran, Prof. &
Head, Dept. of Physics, SIST**

Title: Ultrasonic Techniques and Industrial Application

Date : 21.8.2020



**Dr. B. Sheela Rani
Director (Research), SIST**

Title: NDE- Imaging and Signal analysis Techniques

Date : 25.8.2020

For Registration link :

E – Certificate will be given to the successfully completed participants

Contact : Shri. M.M. Nickolas [Email: niikko57@gmail.com : Mobile: 9789584024

